



5.0mm Both Side Entry Screwless Connnector

1. Purpose:

This is qualification test. The purpose of this test is to evaluate the performance of 5.0mm Both Side Entry Screwless Connector. Testing was performed on below products to determine it compliance with the requirements of product specification

2. Scope:

This is test report for 5.0mm Both Entry Screwless Connector. Testing was performed at TE Connectivity Shanghai Electrical Components Test Laboratory between Oct.27th, 2014 and Nov.16th, 2014.

3. Conclusion:

The product met the electrical, mechanical, and environmental performance requirements of TE product specification

4. Test samples:

Samples were taken randomly from current production. The following part numbers were used for test:

Description	Product Part No.
5.0mm Both Side Entry Screwless Connector	2834014-4

5. Test Method

5.1 Examination of Product

Visual, dimensional and functional per applicable inspection plan.

Requirements: Meets requirements of product drawing

Test Method: In accordance with EIA-364-18

5.2 Contact Resistance

Subject the specimen to maximum allowed rating current and measure the contact resistance.

Requirements: $20m\Omega$ Max. Test Method: EIA-364-23

5.3 Insulation resistance

Unmated connector with 500V DC between adjacent contacts for 1 min.

Requirements: 2000 MΩMin.

Test Method: IEC 60998-1/60998-2-2

5.4 Dielectric strength

Unmated connector with 2000 V AC between adjacent contacts for 1 min.

Requirements: No breakdown.
Test Method: UL1059 Clause 12

Rev. A 1 of 4



5.5 Temperature rise

Measured at maximum rated current with series all contacts.

Current: 10A

Requirement: Temperature rise should be 30°C Max.

Test method: UL1059 Clause 11

5.6 Pullout force

Wire:16AWG_40N / Wire:20AWG_30N

The terminal shall not separate from the wire as a result.

Test method: UL486

5.7 Secureness test

Wire:16AWG(Solid &Stranded) /Duration time:15minutes

The joint between a terminal and the wire of a sample set shall be intact after test.

Test method: UL486

5.8 Low temperature test

Temperature:-40 °C / Humidity:0% / Duration: 24hr

Requirements: Contact resistance $20m\Omega$ Max.

5.9 High temperature test

Temperature: 105 °C / Humidity:0% / Duration: 24hr

Requirements: Contact resistance $20m\Omega$ Max.

5.10 High temperature and high humidity test

Temperature: 40 °C / Humidity:90% / Duration: 24hr

Requirements: Contact resistance $20m\Omega$ Max.

5.11 Temperature life

Subject mated specimens to 115 °C for 48 hours.

Requirements: Contact resistance $20m\Omega$ Max.

Test method: EIA-364-17, Method A

6. Unless otherwise stated, the following environmental conditions prevailed during testing:

Temperature:5℃ to 35℃ Relative Humidity: 45 % to 80%

Rev. A 2 of 4



7. Test Sequence

Test group	A	В	C	D	E	F	G	Н	I
Examination of product	1,3	1,3	1,4	1,4	1,4	1,3	1,3	1,4	1,4
Contact Resistance	2		3	3	3				3
Insulation resistance.		2							
Dielectric Withstanding Voltage							2		
Temperature Rise						2			
Conductor tensile force test(Pull test)								3	
Secureness test								2	
Low temperature test			2						
High temperature test				2					
High temperature and high humidity test					2				
Temperature life									2
Sample size	3	3	3	3	3	3	3	12	3

8. Test Result

Grou p	Test Item	N	Conditio n		Test Resul	Requireme	Judg	
		IN		sample1	sample2	Sample3	nt	ment
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
Α	Contact resistance	3	Final	pass	pass pass pass			Pass
	Examination of Product	3	Final	No physical damage occurred			No abnormal items	Pass
_	Examination of Product	3	Initial	No physic	al damage o	No abnormal items	Pass	
В	Insulation resistance	3	Final	pass	pass	pass	>2000MΩ	Pass
	Examination of Product	3	Final	No physical damage occurred			No abnormal items	Pass
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
С	Low temperature test	3	Final	No electric	city and mech	No abnormal items	Pass	
	Contact resistance	3	Final	pass	pass	pass	<20mΩ	pass
	Examination of Product	3	Final	No physic	al damage o	No abnormal items	Pass	
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
D	High temperature test	3	Final	No electri	city and mech	No abnormal items	Pass	
	Contact resistance	3	Final	pass	pass	pass	<20mΩ	pass
	Examination of Product	3	Final	No physical damage occurred			No abnormal items	Pass

Rev. A 3 of 4



TEST REPORT 501-137078

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	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
E	High temperature and high humidity test	3	Final	No electric	city and mecl	No abnormal items	Pass	
	Contact resistance	3	Final	pass	pass pass pass			pass
	Examination of Product	3	Final	No physica	al damage o	No abnormal items	Pass	
_	Examination of Product	3	Initial No physical damage occurred			ccurred	No abnormal items	Pass
F	Temperature Rise	3	Final	13.1℃	13.6℃	14.8℃	<30℃	Pass
	Examination of Product	Examination of Product 3 Final No physical damage occurred			ccurred	No abnormal items	Pass	
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
G	Withstanding Voltage	3	Final	pass	pass	pass	No breakdown	Pass
	Examination of Product	3	Final	No physica	al damage o	No abnormal items	Pass	
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
	Secureness test (16AWG Stranded)	3	Final	pass	pass pass pass		No separating	Pass
	Secureness test (16AWG Solid)	3	Final	pass	pass	pass	No separating	Pass
	Pull test (16AWG Solid)	3	Final	pass	pass	pass	No separating	Pass
н	Pull test (16AWG Stranded)	3	Final	pass	pass	pass	No separating	Pass
	Pull test (20AWG Solid)	3	Final	pass	pass	pass	No separating	Pass
	Pull test (20AWG Stranded)	3	Final	pass	pass	pass	No separating	Pass
	Examination of Product	3	Final	No physica	al damage o	No abnormal items	Pass	
	Examination of Product	3	Initial	No physical damage occurred			No abnormal items	Pass
ı	Temperature life	3	Final	No electric	city and mecl	No abnormal items	Pass	
	Contact resistance	3	Final	0.71 mΩ		<20mΩ	pass	
	Examination of Product	3	Final	No physica	al damage o	No abnormal items	Pass	

END

Rev. A 4 of 4